



1000V, 42A, 0.20Ω Max, t<sub>rr</sub> ≤400ns

# N-Channel FREDFET

Power MOS  $8^{\text{TM}}$  is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced  $t_{rr}$ , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of  $C_{rss}/C_{iss}$  result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



APT41F100J
Single die FREDFET



### **FEATURES**

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C<sub>rss</sub> for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

### **TYPICAL APPLICATIONS**

- · ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

**Absolute Maximum Ratings** 

Symbol	Parameter	Ratings	Unit
l <sub>a</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	42	
'D	Continuous Drain Current @ T <sub>C</sub> = 100°C	27	Α
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	260	
V <sub>GS</sub>	Gate-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ©	4075	mJ
I <sub>AR</sub>	Avalanche Current, Repetitive or Non-Repetitive	33	Α

#### **Thermal and Mechanical Characteristics**

Symbol	Characteristic		Тур	Max	Unit	
P <sub>D</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C			960	W	
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.13	0.13 °C/W	
R <sub>ecs</sub>	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range	-55		150	°C	
V <sub>Isolation</sub>	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V	
W <sub>T</sub>	Package Weight		1.03		OZ	
			29.2		g	
Torque	Tamping land Manusking Courses		·	10	in·lbf	
	Terminals and Mounting Screws.			1.1	N·m	

<u> </u>						
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V <sub>BR(DSS)</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250 \mu A$	1000			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> = 25	50µA	1.15		V/°C
R <sub>DS(on)</sub>	Drain-Source On Resistance <sup>③</sup>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 33A		0.18	0.20	Ω
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage	\/ -\/   - Fm \	2.5	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_D = 5mA$	`	-10		mV/°C
I <sub>DSS</sub>	Zoro Cata Valtaga Drain Current	$V_{DS} = 1000V$ $T_{J} = 25^{\circ}C$			250	μA
	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ $T_J = 125^\circ$	,C		1000	] μΑ
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±30V			±100	nA

**APT41F100J** 

#### **Dynamic Characteristics** T<sub>J</sub> = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
9 <sub>fs</sub>	Forward Transconductance	$V_{DS} = 50V, I_{D} = 33A$		75		S
C <sub>iss</sub>	Input Capacitance	V 0V V 05V		18500		
$C_{rss}$	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		245		
C <sub>oss</sub>	Output Capacitance	1 111112		1555		
$C^{o(cr)} \oplus$	Effective Output Capacitance, Charge Related	V = 0V V = 0V to 667V		635		pF
C <sub>o(er)</sub> ⑤	Effective Output Capacitance, Energy Related	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 667V		325		
$Q_g$	Total Gate Charge	)/ 01×40)/ 1 00A		570		
$Q_{gs}$	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 33A,$		100		nC
$Q_{gd}$	Gate-Drain Charge	V <sub>DS</sub> = 500V		270		
t <sub>d(on)</sub>	Turn-On Delay Time	Resistive Switching		55		
t <sub>r</sub>	Current Rise Time	V <sub>DD</sub> = 667V, I <sub>D</sub> = 33A		55		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		235		115
t <sub>f</sub>	Current Fall Time			55		1

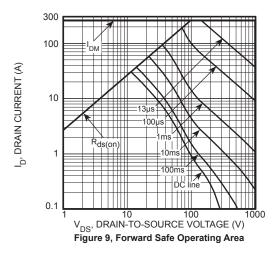
#### Source-Drain Diode Characteristics

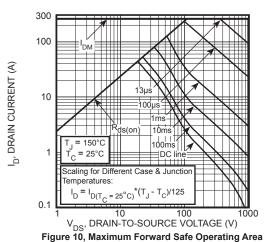
Symbol	Parameter	Test Conditions	s Mir	т Тур	Max	Unit
Is	Continuous Source Current (Body Diode)	MOSFET symbol showing the	OD D		42	Α
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>①</sup>	integral reverse p-n junction diode (body diode)	SUPPLY S		260	
V <sub>SD</sub>	Diode Forward Voltage	$I_{SD} = 33A, T_{J} = 25^{\circ}C, V_{GS}$	S = 0V		1.2	V
t <sub>rr</sub>	Reverse Recovery Time  Reverse Recovery Charge	T <sub>J</sub> = 2	25°C		400	no
`rr		$T_J = 1$	125°C		800	ns
Q <sub>rr</sub>		$I_{SD} = 33A^{3}$ $T_{J} = 2$	25°C	3.3		
arr.		$V_{DD} = 100V$ $T_{J} = 1$	125°C	8.0		μC
1	Reverse Recovery Current	$di_{SD}/dt = 100A/\mu s$ $T_J = 2$	25°C	17.2		_
'rrm		T <sub>J</sub> = 125°C		24.6		- A
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 33A$ , di/dt $\le 1000A/\mu s$ , $V_{DD} = 667V$ , $T_{J} = 125^{\circ}C$			25	V/ns

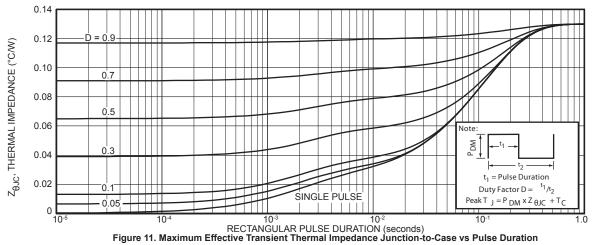
- ① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at  $T_J = 25^{\circ}\text{C}$ , L = 7.48mH,  $R_G = 25\Omega$ ,  $I_{AS} = 33A$ .
- (3) Pulse test: Pulse Width < 380µs, duty cycle < 2%.

- $\bigcirc$  R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

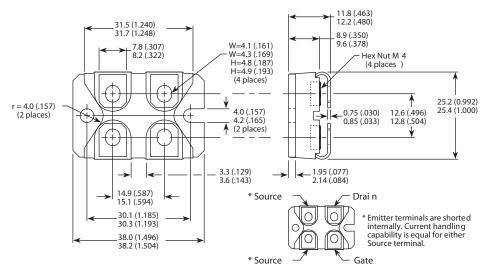
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## SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)